

Agilent L4452A Multifunction with Digital I/O, D/A, Totalizer

Data Sheet

- LXI compliance includes built-in Ethernet connectivity
- Fully-featured graphical Web interface
- 32-bits of digital I/O up to 42 V
- 100 kHz gated totalizer
- Two ±12 V analog outputs with 1 mV of resolution
- Software drivers for most common programming environments



Multifunction instrument offers your system control functionality wherever your application needs it

The Agilent L4452A is a multifunction instrument that is LXI Class C compliant. With its small size and Ethernet connectivity, this multifunction instrument can be placed wherever your application needs it.

The Agilent L4452A allows great flexibility for a variety of sense and control applications.

It combines four 8-bit channels of digital input and output, a 100 kHz gated totalizer, and two ±12 V analog outputs all on a single earth-referenced module.

Using this LXI instrument, you'll get all the benefits of an Ethernet connection, instrument Web server, standard software drivers and more. The LXI standard is supported by multiple vendors, enabling lower cost of test with accelerated test integration and development.

Digital I/O, D/A converter and totalizer for your most common test requirements

The L4452A combines digital I/O, analog outputs and a gated totalizer for your most common system control needs.

The digital I/O supports output levels up to 42 V. These channels can be used with an external power supply to control external devices or to sense limit switch and digital bus status with no complex handshake modes.

You can use the totalizer input to count events. The digital inputs and totalizer inputs may be included in a scan. Alarm limits for the digital and event counter inputs are evaluated continuously, capturing and logging alarm conditions even between scans.

The analog outputs can output up to ±12 V or 10 mA DC with 1 mV of resolution. They can be used to source bias voltages to your device under test, to control your analog programmable power supplies, or use the outputs as set points for your control systems.

External trigger capabilities make it easy for you to time and synchronize measurements and other events. This can help you determine when to begin or end a scan.

System connections you can trust

The L4452A comes with one heavy duty 50-pin Dsub connector that allows for simple, reliable connection options. Each connector uses 30 micro-inches of gold to ensure a repeatable, accurate measurement. Flexible connection options include:

- Detachable terminal blocks with strain relief
- Low-cost, standard 50-pin Dsub connector kits and cables
- Mass interconnect solutions

Ethernet connectivity enables simple connection to the network and remote access to measurements

The Ethernet interface offers high-speed connections that allow for remote access and control. You can set up a private network to filter out unwanted LAN traffic and speed up the I/O throughput, or take advantage of the remote capabilities and distribute your tests worldwide. Monitor, troubleshoot, or debug your application remotely. Ethernet communication also can be used with the support of LAN sockets connections.

The optional GPIB interface has many years of proven reliability and can be used for easy integration into existing applications.

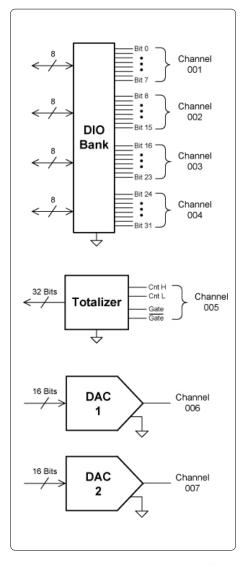


Figure 1. L4452A Multifunction Digital I/O, D/A, totalizer

The L4452A ships with the Agilent E2094N I/O Libraries Suite making it easy for you to configure and integrate instruments into your system — even if your system includes instruments from multiple vendors.

Fully-featured graphical Web interface makes it easy to set-up and troubleshoot your tests from anywhere in the world

The built-in Web browser interface provides remote access and control of the instrument via a Java-enabled browser such as Internet Explorer. Using the Web interface, you can set up, troubleshoot, and maintain your instrument from remote locations.

- View and modify instrument setup
- Configure I/O channels, analog outputs, totalizer and alarms
- Read and write I/O channels
- Output analog channels
- View error queue
- Get status reports, current configuration, firmware revisions, and more

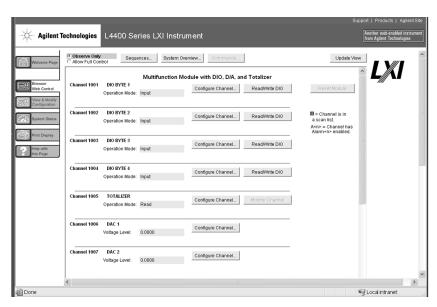


Figure 2. The Web interface makes it easy to set up, troubleshoot and maintain your test remotely

Additionally, since the Web server is built into the instrument, you can access it on any operating system that supports the Web browser without having to install any special software. Password protection and LAN lockout are also provided to limit access for additional security.

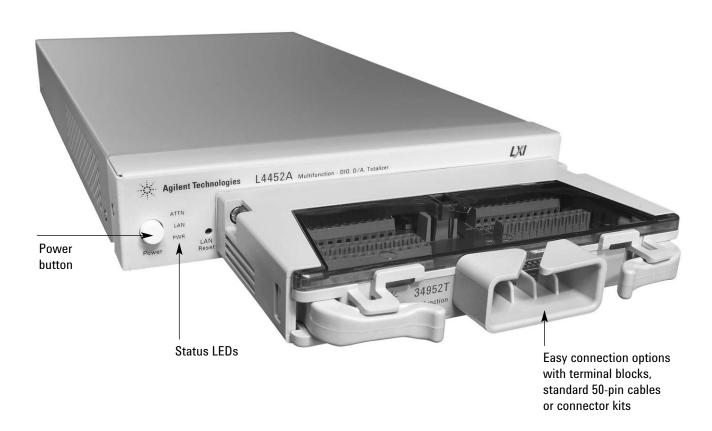
Software for most popular programming environments

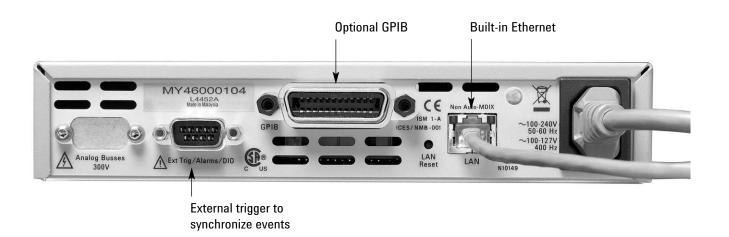
Full support for standard programming environments ensures compatibility and efficiency. You can use direct I/O with the software you

already have and know, or use standard IVI and LabVIEW™ software drivers that provide compatibility with the most popular development environments:

- Agilent T&M Toolkit for Microsoft Visual Studio[®].NET and Agilent VEE Pro
- National Instruments LabVIEW, LabWindows/CVI, TestStand, and Switch Manager
- Microsoft C/C++® and Visual Basic®

Multifunction instrument wherever your application needs it





Product Specifications

Specifications and Characteristics

Digital input/output characteristics		
Four 8-bits channels, 8 bits wide, input or output, non-isolated	Vin(L)	< 0.8 V (TTL)
	Vin(H)	> 2.0 V (TTL)
	Vout(L)	< 0.8 V @ lout = -400 mA
	Vout(H)	> 2.4 V @ lout = 1 mA
	Vin(H) max	< 42 V with external open drain pull-up
	Alarm	Maskable pattern match or state change

Read/write speed

Speed

Totalize input characteristics

Max count	2 ²⁶ - 1
Totalize input	100 kHz (max) rising or falling edge, programmable
Signal level	1 Vp-p (min) 42 Vpk (max)
Threshold	0 V or TTL
Gate input	TTL-Hi, TTL-Lo, or none
Count reset	Manual or read + reset
Read speed	85 rdgs/s

95/s

4 ms (max) alarm sampling Latency

Analog output characteristics

DAC 1, 2	±12 V, non-isolated
Resolution	1 mV
IOUT	10 mA max
Settling time	1 ms to 0.01% of output
Accuracy	±(% of output + mV) 1 year (0.25% + 20 mV)
Temp. coefficient	±(0.015% + 1 mV)/°C

Product Specifications (continued)

data transfer rate with	1000 channel blocks)	GPIB	LAN (w/ VXI 11)
		rds/s	rds/s
	Readings	2560	3542
	readings with timestamp	1304	1826
	readings with all format options ON	980	1361
Scan triggering			
	Source	Interval, external,	software, or on monitor channel alarm
	Scan count	1 to 50,000 or continuous	
	Scan interval	0 to 99 hours; 1 m	is step size
	Channel delay	0 to 60 seconds p	er channel; 1 ms step size
	External trig delay	<2 ms. With mon	itor on <200 ms
	External trig jitter	<2 ms	
Alarms			
	Digital inputs	Digital in maskab Totalize: Hi limit o	le pattern match or state change nly
	Alarm on channel	Alarm evaluated e	each reading
	Alarm outputs	2 TTL compatible,	Selectable TTL logic Hi or Lo on fail
	Latency	5 ms (typical)	
Memory			
	Туре	Volatile	
	Readings	500,000 with time	stamp Readable during scan
	States	5 instrument state	es with user label in non-volatile memory
General specifications			
deneral specifications	Power supply	Universal 100 V to	240 V ±10%
	Power line frequency	50 Hz to 60 Hz ±1	0% automatically sensed
	Power consumption	15 VA	
	Operating Environment	Full accuracy for 0 Full accuracy to 80 Pollution degree 1	1% R.H. at 40 °C
	Storage environment	-40°C to 70°C	
	Dimensions (H x W x L)	40.9 x 212.3 x 379 1.61 x 8.36 x 14.93	
	Weight	3.6 kg, 8 lbs	
	Safety conforms to	CSA, UL/IEC/EN	61010-1
	EMC conforms to	IEC/EN 61326-1,	CISPR 11
	Warranty	1 year	

Product Specifications (continued)

	Agilent connectivity software included	Agilent I/O Libraries Suit	te 14 or greater (E2094N)
Minimum system requ	irements		
	PC hardware	Intel Pentium 100 MHz, 6	64 Mbyte RAM, 210 Mbyte disk spac
		Display 800x600, 256 col	ors, CD-ROM drive
	Operating system ¹	Windows [®] 98 SE/NT/20	000/XP
Computer interfaces			
		Standard LAN 10BaseT/100BaseTx	
		Optional IEEE 488.2 GPIB	
Software driver suppo	rt for programming languages	N/1 0	T. I. NIT® (0000 (V/D
Software driver suppo	rt for programming languages		
Software driver suppo	rt for programming languages Software drivers	IVI-C and IVI-COM for W	indows NT [®] /2000/XP
Software driver suppo	Software drivers	LabVIEW	indows NT®/2000/XP
Software driver suppo	Software drivers	LabVIEW ing tools and environments	
Software driver suppo	Software drivers	LabVIEW	VEE Pro T&M Toolkit (reqs Visual Studio.NET)
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Software driver suppo	Software drivers	LabVIEW ing tools and environments Agilent	VEE Pro T&M Toolkit (reqs Visual Studio.NET) TestStand Measurement Studio
Software driver suppo	Software drivers	LabVIEW ing tools and environments Agilent	VEE Pro T&M Toolkit (reqs Visual Studio.NET) TestStand Measurement Studio LabWindows/CVI
Software driver suppo	Software drivers	LabVIEW ing tools and environments Agilent	VEE Pro T&M Toolkit (reqs Visual Studio.NET) TestStand Measurement Studio LabWindows/CVI LabVIEW
Software driver suppo	Software drivers	LabVIEW ing tools and environments Agilent National Instruments	VEE Pro T&M Toolkit (reqs Visual Studio.NET) TestStand Measurement Studio LabWindows/CVI LabVIEW Switch Executive

 $^{^{\}rm 1}$ Load I/O Libraries Version M for Windows NT support or version 14.0 for Windows 98 SE support

Ordering information

L4452A Multifunction instrument with digital I/O, D/A converters and totalizer

Includes User's guide on CD, power cord, and Quick Start package

Option -GPIB

Adds GPIB interface

Option 0B0

Deletes printed manual set, full documentation included on CD ROM

Option ABA

English printed manual set

Connection Options

Select terminal block for discrete wiring, cables or connector kits. Cables and connector kits require one per instrument.

34952T

Terminal block for 34952A and L4452A Multifunction

Y1135A

1.5 m 50-pin Dsub, M/F twisted pair with outer shield cable – 300 V

Y1136A

3~m 50-pin Dsub, M/F twisted pair with outer shield cable – 300~V

Y1141A

Solder cup connector kit with male 50-pin Dsub

Other accessories

Y1160A
Rack mount kit for
L4400 series instrumentsracks 2 instruments side-by-side
with slide tray

For additional information please visit:

http://www.agilent.com/find/L4452A

Related Agilent literature

Data Sheets

5988-6302EN Agilent VEE Pro

5989-1441EN Agilent W1140A-TKT

T&M Toolkit 2.0 with Test Automation

5989-1439EN Agilent E2094N I/O Libraries Suite 14

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